

<b>Notice of References Cited</b>	Application/Control No. 10/069,459	Applicant(s)/Patent Under Reexamination UCHIDA ET AL.	
	Examiner Dah-Wei D. Yuan	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,641,862	11-2003	Grot, Stephen Andreas	427/115
	C	US-			
	D	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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